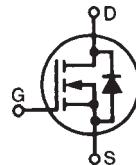


PolarHT™ HiPerFET Power MOSFET

IXFK 140N20P

N-Channel Enhancement Mode
Avalanche Rated
Fast Intrinsic Diode

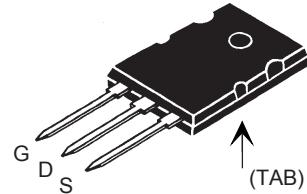
V_{DSS} = 200 V
I_{D25} = 140 A
R_{DS(on)} ≤ 18 mΩ
t_{rr} ≤ 200 ns



Symbol	Test Conditions	Maximum Ratings		
V_{DSS}	T _J = 25°C to 175°C	200		V
V_{DGR}	T _J = 25°C to 175°C; R _{GS} = 1 MΩ	200		V
V_{GS}	Continous	±20		V
V_{GSM}	Transient	±30		V
I_{D25}	T _C = 25°C	140	A	
I_{D(RMS)}	External lead current limit	75	A	
I_{DM}	T _C = 25°C, pulse width limited by T _{JM}	280	A	
I_{AR}	T _C = 25°C	60	A	
E_{AR}	T _C = 25°C	100	mJ	
E_{AS}	T _C = 25°C	4	J	
dv/dt	I _S ≤ I _{DM} , di/dt ≤ 100 A/μs, V _{DD} ≤ V _{DSS} , T _J ≤ 150°C, R _G = 4 Ω	10	V/ns	
P_D	T _C = 25°C	830		W
T_J		-55 ... +175		°C
T_{JM}		175		°C
T_{stg}		-55 ... +150		°C
T_L	1.6 mm (0.062 in.) from case for 10 s	300		°C
T_{SOLD}	Plastic body for 10 s	260		°C
M_d	Mounting torque	1.13/10	Nm/lb.in.	
Weight		10		g

Symbol	Test Conditions (T _J = 25°C, unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
BV_{DSS}	V _{GS} = 0 V, I _D = 250 μA	200		V
V_{GS(th)}	V _{DS} = V _{GS} , I _D = 4 mA	2.5		V
I_{GSS}	V _{GS} = ±20 V _{DC} , V _{DS} = 0		±200	nA
I_{DSS}	V _{DS} = V _{DSS} V _{GS} = 0 V		25 250	μA
R_{DS(on)}	V _{GS} = 10 V, I _D = 0.5 I _{D25} V _{GS} = 15 V, I _D = 140 A Pulse test, t ≤ 300 μs, duty cycle d ≤ 2 %	14	18	mΩ

TO-264 (IXFK)



G = Gate
S = Source

D = Drain
TAB = Drain

Features

- ^ International standard package
- ^ Unclamped Inductive Switching (UIS) rated
- ^ Low package inductance
 - easy to drive and to protect

Advantages

- ^ Easy to mount
- ^ Space savings
- ^ High power density

Symbol Test Conditions

Characteristic Values

(T_J = 25°C, unless otherwise specified)

Min. Typ. Max.

g_{fs}	V _{DS} = 10 V; I _D = 0.5 I _{D25} , pulse test	50	84	S
C_{iss} C_{oss} C_{rss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1 MHz	7500	pF	
		1800	pF	
		280	pF	
t_{d(on)} t_r t_{d(off)} t_f	V _{GS} = 10 V, V _{DS} = 0.5 V _{DSS} , I _D = 60 A R _G = 3.3 Ω (External)	30	ns	
		35	ns	
		150	ns	
		90	ns	
Q_{g(on)} Q_{gs} Q_{gd}	V _{GS} = 10 V, V _{DS} = 0.5 V _{DSS} , I _D = 0.5 I _{D25}	240	nC	
		50	nC	
		100	nC	
R_{thJC}			0.18	°C/W
R_{thcs}		0.15		°C/W

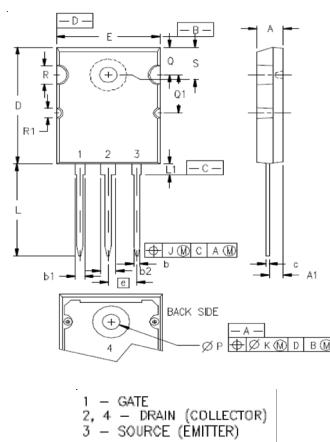
Source-Drain Diode

Characteristic Values

(T_J = 25°C, unless otherwise specified)

Symbol	Test Conditions	Min.	Typ.	Max.
I _s	V _{GS} = 0 V			140 A
I _{SM}	Repetitive			280 A
V _{SD}	I _F = I _s , V _{GS} = 0 V, Pulse test, t ≤ 300 μs, duty cycle d ≤ 2 %			1.5 V
t_{rr} Q_{RM}	I _F = 25 A -di/dt = 100 A/μs	120	200	ns
	V _R = 100 V, V _{GS} = 0 V		3.5	μC

TO-264 (IXFK) Outline

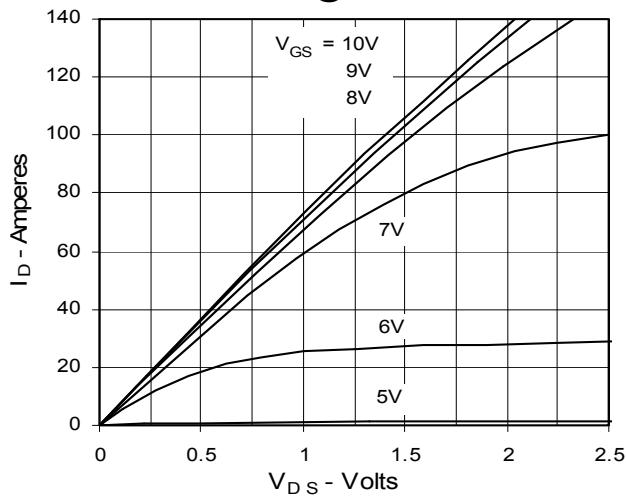


SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.185	.209	4.70	5.31
A1	.102	.118	2.59	3.00
b	.037	.055	0.94	1.40
b1	.087	.102	2.21	2.59
b2	.110	.126	2.79	3.20
c	.017	.029	0.43	0.74
D	1.007	1.047	25.58	26.59
E	.760	.799	19.30	20.29
e	.215 BSC		5.46 BSC	
J	.000	.010	0.00	0.25
K	.000	.010	0.00	0.25
L	.779	.842	19.79	21.39
L1	.087	.102	2.21	2.59
ØP	.122	.138	3.10	3.51
Q	.240	.256	6.10	6.50
Q1	.330	.346	8.38	8.79
ØR	.155	.187	3.94	4.75
ØR1	.085	.093	2.16	2.36
S	.243	.253	6.17	6.43

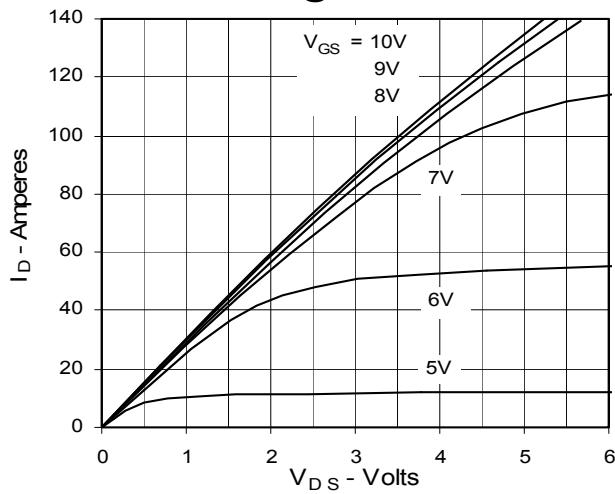
IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585 one or more of the following U.S. patents: 4,850,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405B2 6,759,692 4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6,771,478 B2

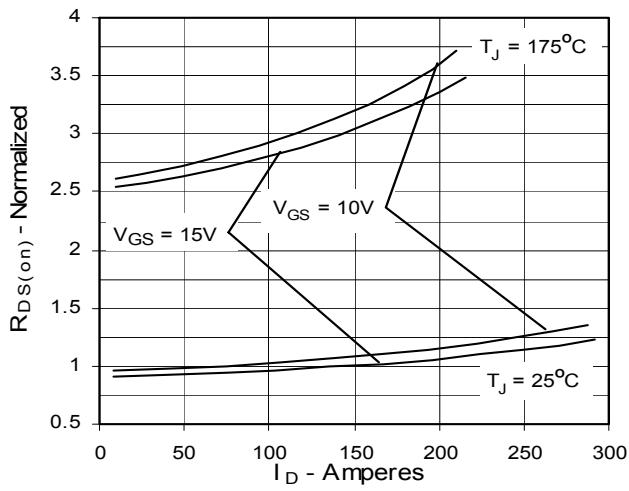
**Fig. 1. Output Characteristics
@ 25°C**



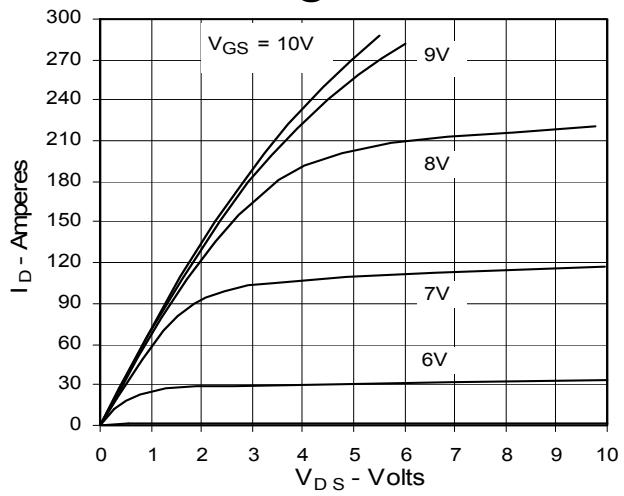
**Fig. 3. Output Characteristics
@ 150°C**



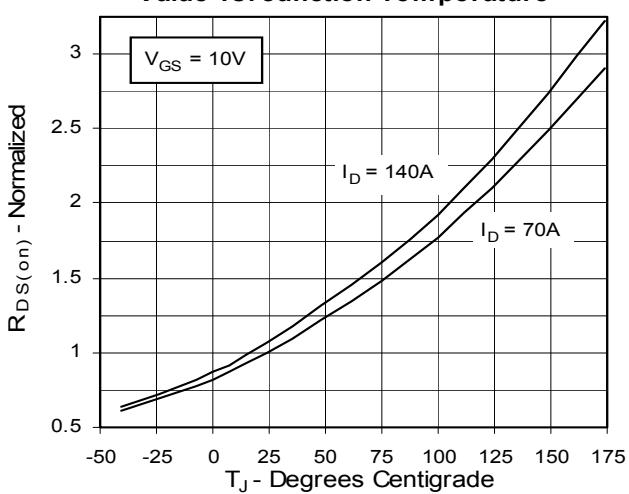
**Fig. 5. $R_{DS(on)}$ Normalized to 0.5 I_{D25}
Value vs. Drain Current**



**Fig. 2. Extended Output Characteristics
@ 25°C**



**Fig. 4. $R_{DS(on)}$ Normalized to 0.5 I_{D25}
Value vs. Junction Temperature**



**Fig. 6. Drain Current vs. Case
Temperature**

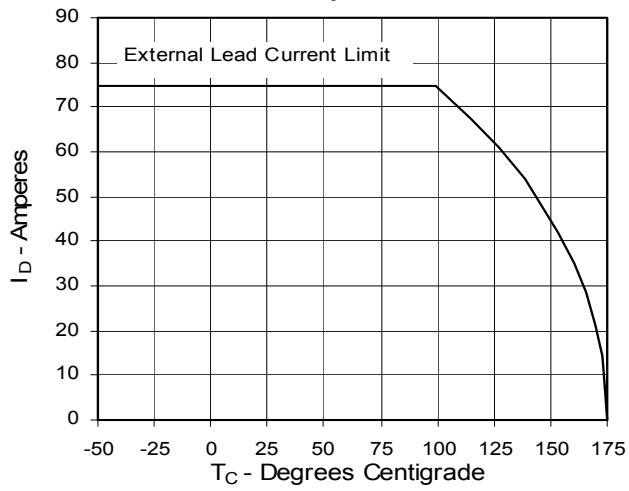


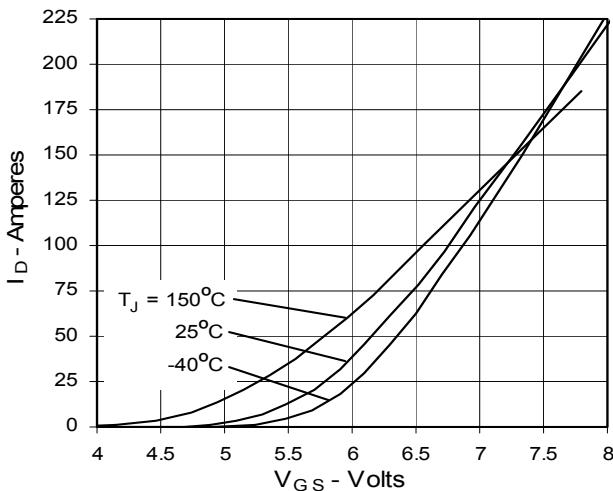
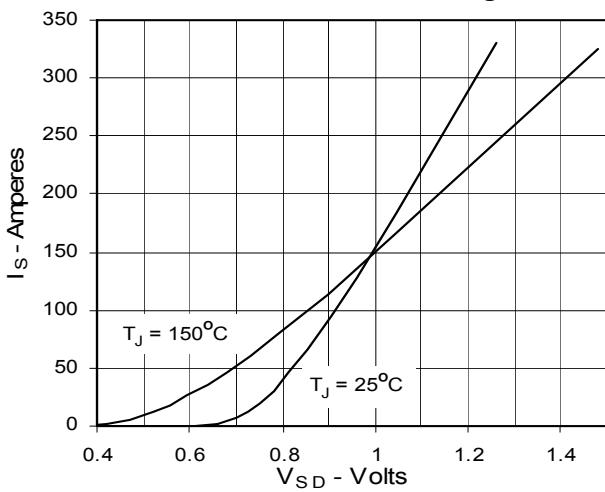
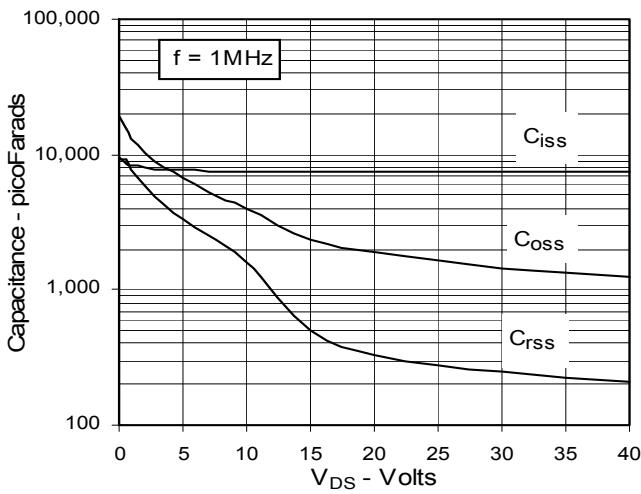
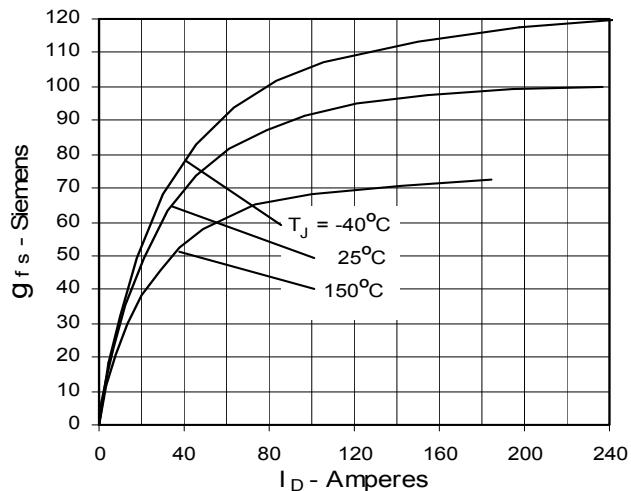
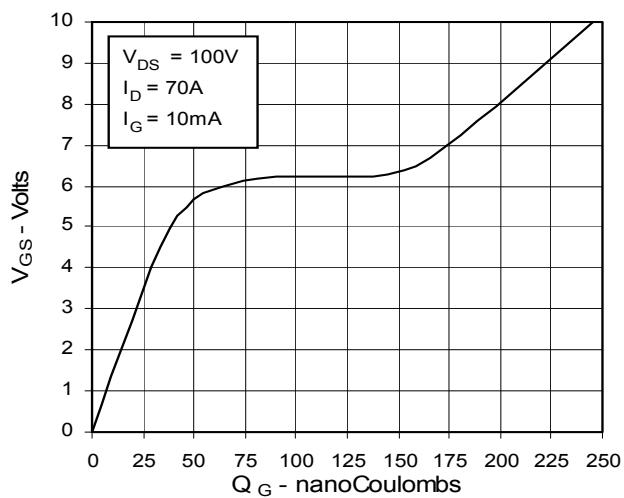
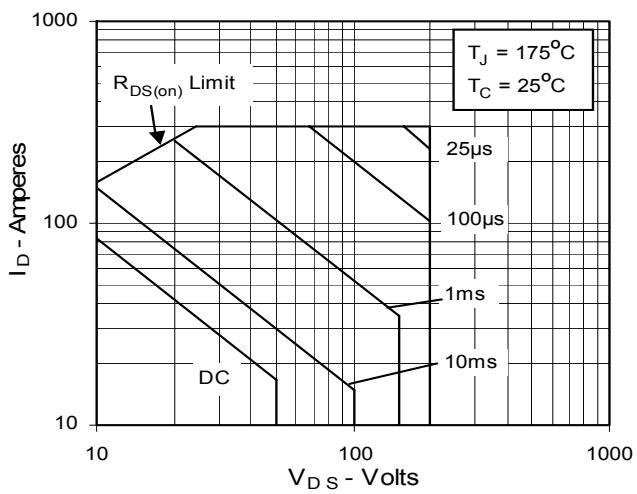
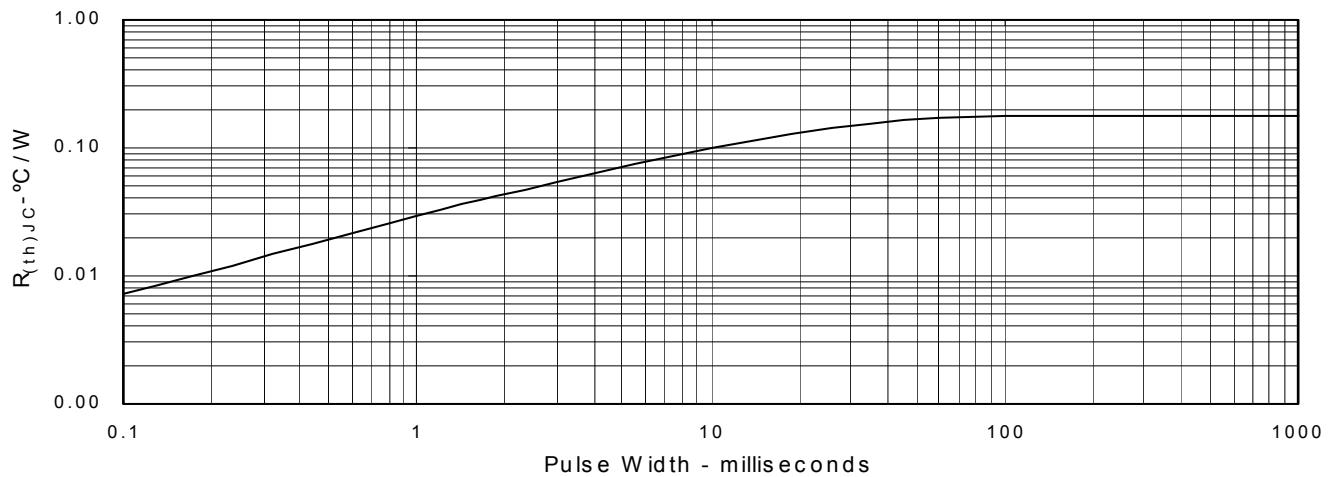
Fig. 7. Input Admittance

Fig. 9. Source Current vs. Source-To-Drain Voltage

Fig. 11. Capacitance

Fig. 8. Transconductance

Fig. 10. Gate Charge

Fig. 12. Forward-Bias Safe Operating Area


Fig. 13. Maximum Transient Thermal Resistance



Disclaimer Notice - Information furnished is believed to be accurate and reliable. However, users should independently evaluate the suitability of and test each product selected for their own applications. Littelfuse products are not designed for, and may not be used in, all applications. Read complete Disclaimer Notice at www.littelfuse.com/disclaimer-electronics.